

Notice of References Cited

Application/Control No.

10/262,567

Applicant(s)/Patent Under
Reexamination
WILLIAMS ET AL.

Examiner

Mary Wilczewski

Art Unit

2822

Page 1 of 4

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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MW	C	US-2003/0132453	07-2003	Greenberg et al.	257/197
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MW	L	US-5,817,546	10-1998	Ferla et al.	438/138
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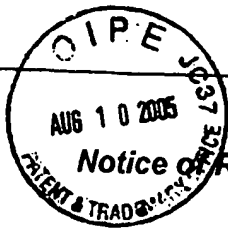
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	Examiner Mary Wilczewski	Art Unit 2822	Page 2 of 4

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		Examiner Mary Wilczewski	Art Unit 2822	Page 3 of 4

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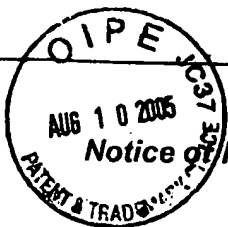
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Page 4 of 4

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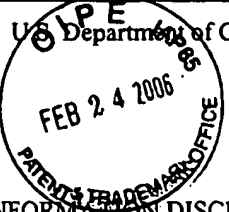
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 <p>U.S. Department of Commerce, Patent and Trademark Office</p> <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(Use several sheets if necessary)</p>	Application No.:	10/767,419
	Filing Date:	01/29/2004
	First Named Inventor:	Richard K. Williams
	Group Art Unit:	2822
	Examiner Name:	Unknown
	Confirmation No.:	4453
	Attorney Docket No.:	AAT007-2C US

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	Confirmation No.:	4453
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